Scientific Publications Dr. Christian David past 10 years

Last updated: July 2018

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1. P. Juranić, J. Rehanek, C. Pradervand, R. Ischebeck, C. Erny, P. Heimgartner, I. Gorgisyan, G. Seniutinas, C. David, C. Hauri and L. Patthey
SwissFEL Aramis Beamline Photon Diagnostics
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2. G. Seniutinas, A. Weber, C. Padeste, I. Sakellari, M. Farsari, and C. David
Beyond 100 nm Resolution in 3D Laser Lithography – Post Processing Solutions
Microelectronic Engineering **191** (2018) p. 25-31

3. B. Rösner, F. Koch, F. Döring, J. Bosgra, V.A. Guzenko, E. Kirk, M. Meyer, J.L. Ornelas, R.H. Fink, S. Swaraj, R. Belkhou, B. Watts, J. Raabe, C. David
Exploiting Atomic Layer Deposition for Fabricating Sub-10 nm X-ray Lenses
Microelectronic Engineering **191** (2018) p. 91–96

4. A. Cattoni, D. Mailly, O. Dalstein, M. Faustini, G. Seniutinas, B. Rösner, C. David
Sub-10 nm Electron and Helium Ion Beam Lithography Using a Recently Developed Alumina Resist
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5. M. Graczyk, A. Cattoni, B. Rösner, G. Seniutinas, A. Kvennefors, A. Löfstrand, D. Mailly, C. David, I. Maximov
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6. M.P. Olbinado, J. Grenzer, A. Pelka, P. Pradel, T. De Resseguier, P. Vagovic, M.-C. Zdora, V.G. Guzenko, C. David, and A. Rack
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